

Search Notes

Application/Control No.

10/500,563

Examiner

David J. Venci

Applicant(s)/Patent under
Reexamination

LAROCHE, PASCALE

Art Unit

1641

SEARCHED

Class	Subclass	Date	Examiner
435	174,177- 181,967	5/23/2007	DV
436	523	5/23/2007	DV
436	528-534	5/23/2007	DV
436	8,10,15,16	5/23/2007	DV
436	52	5/23/2007	DV
250	367	5/23/2007	DV
356	243.2	5/23/2007	DV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EASTWEST - see attached	5/23/2007	DV
PALM - inventor name search	5/23/2007	DV
WILEY INTERSCIENCE - CURRENT PROTOCOLS IN CYTOMETRY	5/23/2007	DV